1.2V Drive Pch MOSFET

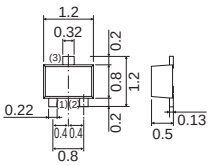
RZM002P02

●Structure
Silicon P-channel MOSFET

●Features
1) High Speed Switching.
2) Small package (VMT3).
3) Ultra Low Voltage drive. (1.2V drive)

●Dimensions (Unit : mm)

VMT3
SOT-723

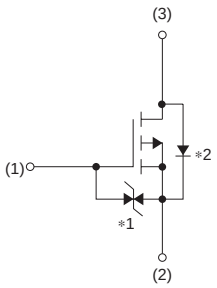


(1)Gate
(2)Source
(3)Drain

Abbreviated symbol : YK

●Applications
Switching

●Inner circuit



∗1 ESD PROTECTION DIODE
∗2 BODY DIODE

(1) Gate
(2) Source
(3) Drain

●Packaging specifications

Type	Package	Taping
	Code	T2L
	Basic ordering unit (pieces)	8000
RZM002P02		◯

●Absolute maximum ratings (Ta=25°C)

Parameter		Symbol	Limits	Unit
Drain-source voltage		V_{DSS}	−20	V
Gate-source voltage		V_{GSS}	±10	V
Drain current	Continuous	I_D	±200	mA
	Pulsed	I_{DP} ∗1	±800	mA
Source current (Body diode)	Continuous	I_S	−100	mA
	Pulsed	I_{SP} ∗1	−800	mA
Total power dissipation		P_D ∗2	150	mW
Channel temperature		Tch	150	°C
Range of storage temperature		Tstg	−55 to +150	°C

∗1 Pw≤10µs, Duty cycle≤1%
∗2 Each terminal mounted on a recommended land

●Thermal resistance

Parameter	Symbol	Limits	Unit
Channel to ambient	Rth(ch-a)∗	833	°C/W

∗ Each terminal mounted on a recommended land

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●Electrical characteristics (Ta=25°C)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Gate-source leakage	I_{GSS}	–	–	±10	μA	V_{GS}= ±10V, V_{DS}=0V
Drain-source breakdown voltage	$V_{(BR)\ DSS}$	–20	–	–	V	I_D= –1mA, V_{GS}=0V
Zero gate voltage drain current	I_{DSS}	–	–	–1	μA	V_{DS}= –20V, V_{GS}=0V
Gate threshold voltage	$V_{GS\ (th)}$	–0.3	–	–1.0	V	V_{DS}= –10V, I_D= –100uA
Static drain-source on-state resistance	$R_{DS\ (on)}$*	–	0.8	1.2	Ω	I_D= –200mA, V_{GS}= –4.5V
		–	1.0	1.5	Ω	I_D= –100mA, V_{GS}= –2.5V
		–	1.3	2.2	Ω	I_D= –100mA, V_{GS}= –1.8V
		–	1.6	3.5	Ω	I_D= –40mA, V_{GS}= –1.5V
		–	2.4	9.6	Ω	I_D= –10mA, V_{GS}= –1.2V
Forward transfer admittance	$\|Y_{fs}\|$ *	0.2	–	–	S	V_{DS}= –10V, I_D= –200mA
Input capacitance	C_{iss}	–	115	–	pF	V_{DS}= –10V
Output capacitance	C_{oss}	–	10	–	pF	V_{GS}= 0V
Reverse transfer capacitance	C_{rss}	–	6	–	pF	f=1MHz
Turn-on delay time	$t_{d\ (on)}$ *	–	6	–	ns	V_{DD}≒ –10V I_D= –100mA V_{GS}= –4.5V R_L≒100Ω R_G= 10Ω
Rise time	t_r *	–	4	–	ns	
Turn-off delay time	$t_{d\ (off)}$ *	–	17	–	ns	
Fall time	t_f *	–	17	–	ns	
Total gate charge	Q_g *	–	1.4	–	nC	V_{DD}≒ –10V, I_D= –200mA
Gate-source charge	Q_{gs} *	–	0.3	–	nC	V_{GS}= –4.5V
Gate-drain charge	Q_{gd} *	–	0.3	–	nC	R_L≒50Ω, R_G= 10Ω

*Pulsed

●Body diode characteristics (Source-drain) (Ta=25°C)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Forward voltage	V_{SD} *	–	–	–1.2	V	I_S= –200mA, V_{GS}=0V

*Pulsed

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●Electrical characteristic curves

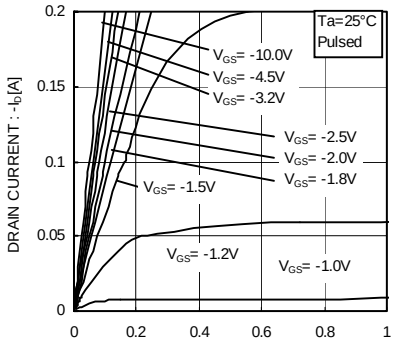

Fig.1 Typical output characteristics(Ⅰ)

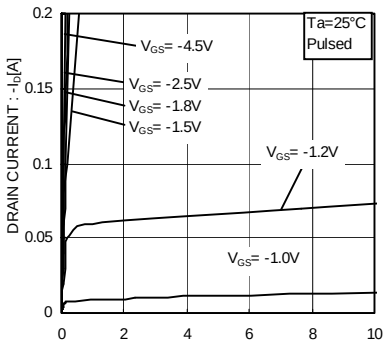

Fig.2 Typical output characteristics(Ⅱ)

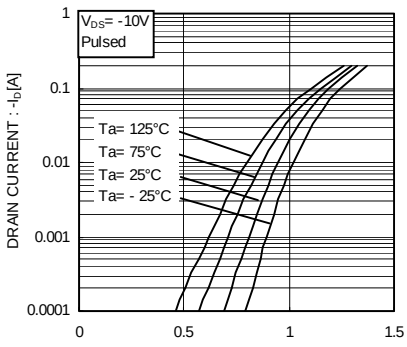

Fig.3 Typical Transfer Characteristics

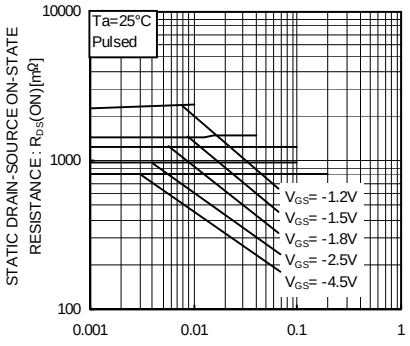

Fig.4 Static Drain-Source On-State Resistance vs. Drain Current(Ⅰ)

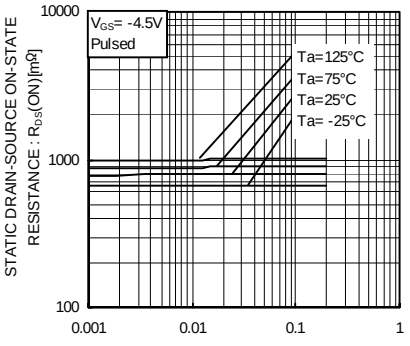

Fig.5 Static Drain-Source On-State Resistance vs. Drain Current(Ⅱ)

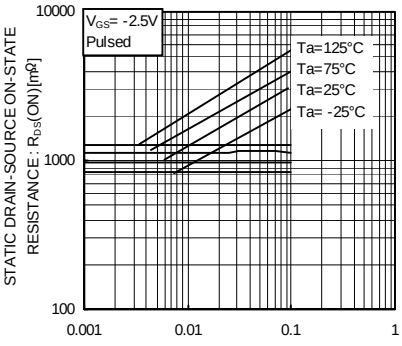

Fig.6 Static Drain-Source On-State Resistance vs. Drain Current(Ⅲ)

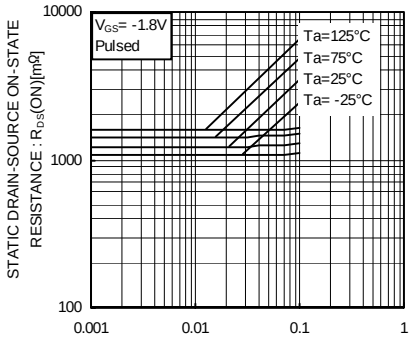

Fig.7 Static Drain-Source On-State Resistance vs. Drain Current(Ⅳ)

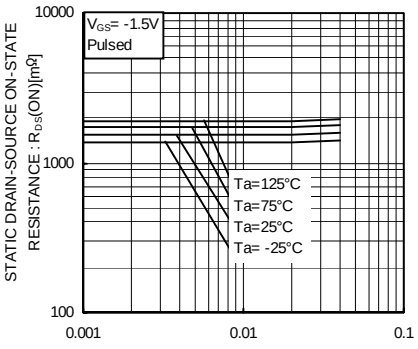

Fig.8 Static Drain-Source On-State Resistance vs. Drain Current(Ⅴ)

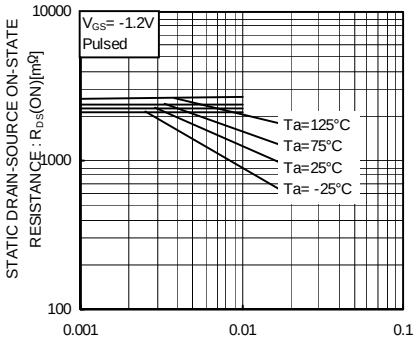

Fig.9 Static Drain-Source On-State Resistance vs. Drain Current(Ⅵ)

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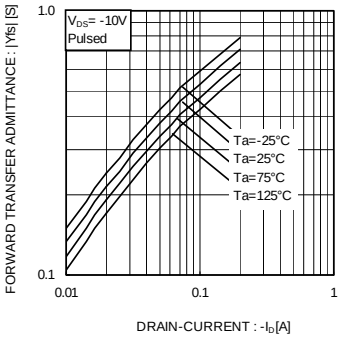

Fig.10 Forward Transfer Admittance vs. Drain Current

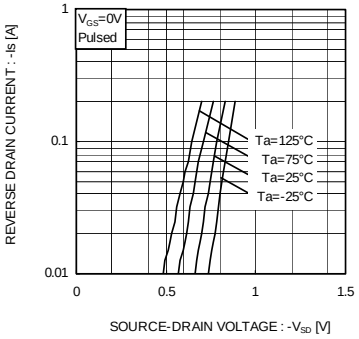

Fig.11 Reverse Drain Current vs. Sourse-Drain Voltage

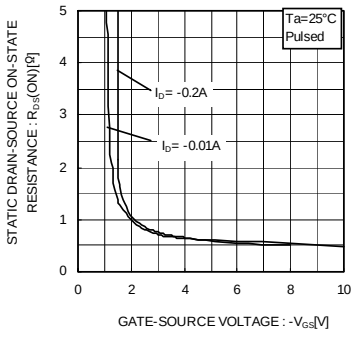

Fig.12 Static Drain-Source On-State Resistance vs. Gate Source Voltage

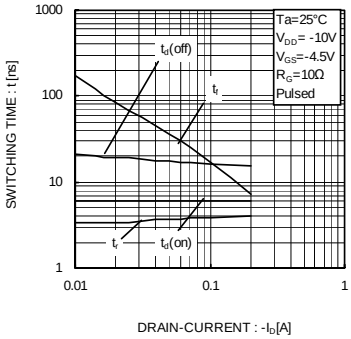

Fig.13 Switching Characteristics

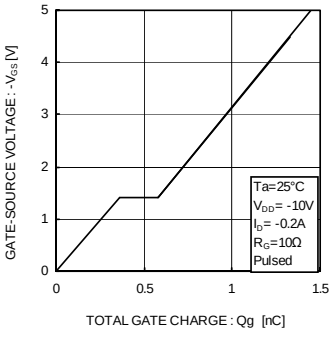

Fig.14 Dynamic Input Characteristics

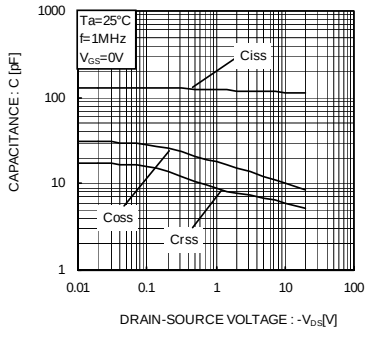

Fig.15 Typical Capacitance vs. Drain-Source Voltage

●Measurement circuit

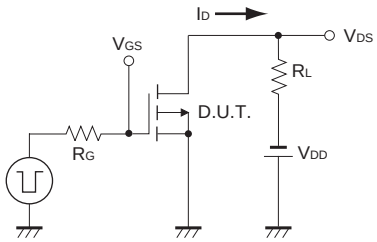

Fig.1-1 Switching Time Measurement Circuit

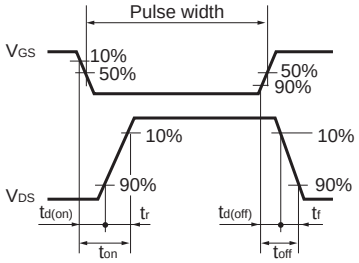

Fig.1-2 Switching Waveforms

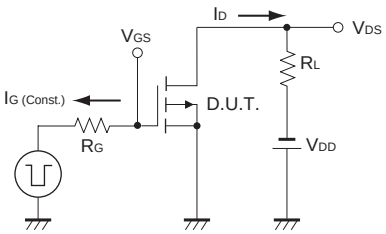

Fig.2-1 Gate Charge Measurement Circuit

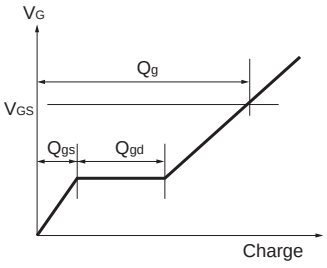

Fig.2-2 Gate Charge Waveform

●Notice

This product might cause chip aging and breakdown under the large electrified environment.
Please consider to design ESD protection circuit.

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